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GE Industrial Systems

**Functional Testing Specification**

*Renewal Services  
Louisville, KY*

**LOU-GED-193X730xx-B**

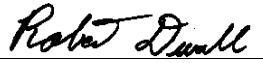
**Test Procedure for a Card**

**DOCUMENT REVISION STATUS:** Determined by the last entry in the "REV" and "DATE" column

REV.	DESCRIPTION	SIGNATURE	REV. DATE
A	Initial release	John Madden	7/2/02
B	Added notes to testing process, section 6.1	John Madden	11/22/02
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<b>DATE</b> 07/02/02	<b>DATE</b>	<b>DATE</b>	<b>DATE</b> 08/09/02

## Functional test procedure for a Reversing Driver card

### 1. SCOPE

1.1 This is a functional testing procedure for a 193X730 Reversing Driver Card.

### 2. STANDARDS OF QUALITY

2.1 Refer to the current revision of the IPC-A-610 standard for workmanship standards.

### 3. APPLICABLE DOCUMENTS

3.1 The following document(s) shall form part of this specification to the extent specified herein. Unless otherwise indicated, the latest issue shall apply.

3.1.1 **193X730xx Documentation Folder**

### 4. ENGINEERING REQUIREMENTS

#### 4.1 Equipment Cleaning

4.1.1 Equipment should be clean and free of debris prior to applying power unless performing an initial check. Refer to the local documented procedures for cleaning guidelines.

#### 4.2 Equipment Inspection

4.2.1 Equipment should be visually inspected for any defects prior to applying power. This inspection should include the following as a minimum:

4.2.1.1 Wires broken or cracked

4.2.1.2 Terminal strips / connectors broken or cracked

4.2.1.3 Loose wires

4.2.1.4 Components visually damaged

4.2.1.5 Capacitors leaking

4.2.1.6 Solder joints damaged or cold

4.2.1.7 Circuit board burned or de-laminated

4.2.1.8 Printed wire runs burned or damaged

### 5. EQUIPMENT REQUIRED

5.1 The following equipment is required to perform the process requirements. Equipment may be substituted provided that all accuracy's and test ratios are equivalent or better.

Qty	Reference #	Description
1		Fluke 85 DMM (or Equivalent)
1	H033535	193X730 test Fixture
1		O-Scope

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## 6. TESTING PROCESS

### 6.1 Setup

**6.1.1** Using BNC to BNC cable, connect scope to test fixture.

**6.1.2** Set fixture to settings listed in procedure below.

**6.1.3** Plug card in and test.



**Note:** It is a good idea to change out all electrolytic caps, UJT's, glass bead diodes, and both 20V zener diodes before testing. These will usually be bad and need replacement anyway, so get it out of the way first.

It is also advisable that if it takes anything other than a 3.01k or 2.74k resistor to get proper saw tooth waveforms on steps 5 & 6, then you may have a bad UJT (even if it's new) on that circuit, and it would be advisable to try to replace it (UJT) one more time and run thru steps 3 & 4 again before re-trying steps 5 & 6.

### 6.2 Testing Procedure

**6.2.1** See following pages

6.1.1 193X730A

- Step 1 Plug card into test box  
Set Scope For 5V per DIV 1ms per DIV  
Set Test Box SW1 to open SW2 to L SW3 to 1
- Step 2 Measure For the following voltages

From To Volts

TP1 TP2 20V+

TP1 TP3 20V-

TP1 TP4 1.5V- \* See Note 1 inside

TP1 TP5 -0.5V- \* See Note 2 P2

TP1 TP6 1.5V+ \* See Note 1 inside

TP1 TP7 0.5V+ \* See Note 2 P1

Note 1: This Voltage can be Adjusted  
inside of test Fixture

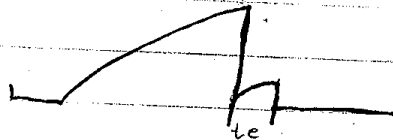
Note 2: This Voltage can be Adjusted  
by P1 and P2 on top of Test  
Fixture

- 6.2.1 Step 3 TURN SW3 to 1 TURN SW2 to 1  
SW3 puts 1.5V+ on tab 5 and 0.5V+ on tab 11  
SW2 looks at tab 12 For Waveform below



Verify that  $t_e$  is between 1.1 and 1.5 milliseconds.  
If not in tolerance remove R238<sup>(60)</sup> and use a  
resistance box to select new value. Disconnect  
resistance box and measure, replace R238 with this  
value. Solder R238 into place and reverify  
 $t_e$  is between 1.1 and 1.5 milliseconds. (higher resistance  
will decrease  $t_e$ )

Step 4 TURN SW 3 to 2 TURN SW 2 to 2  
SW 3 puts 1.5V- on tab 5 and .57V- on tab 8  
SW 2 looks at tab 27 for waveform below



Verify that  $t_e$  is between 1.1 and 1.5 milliseconds.  
If not in tolerance remove R237<sup>(79)</sup> and use a  
resistance box to select new value. Disconnect  
resistance box and measure, replace R237 with this  
value. Solder R237 into place and reverify  $t_e$   
is between 1.1 and 1.5 milliseconds.

Step 5 TURN SW3 to 3 TURN SW2 to 2

SW3 puts 1.5V+ on Tab 5

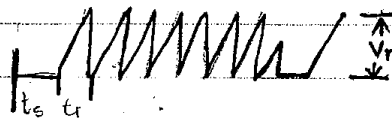
SW2 looks at Tab 27

Verify waveform below

(R2005)

MAKE SURE SW1 ON

TEST BOX IS IN OPEN POS



Verify that output ramps up and down  
with Amplitude of 8V min.

Verify  $t_s$  and  $t_r$

combined are not greater than 2.0 milliseconds

If not correct this can be corrected by Changing

UJT T211 and replacing R206 with 5K pot. Set  
pot to 5K and adjust to get correct waveform  
above

Step 6 TURN SW3 to 3 TURN SW2 to 5

SW3 put 1.5V+ on tab 5

SW2 looks across tab 21 and 25

Verify waveform below



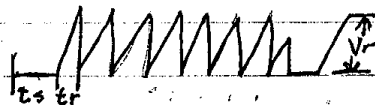
TURN SW2 to 5 SW2 is looking across tab 21 and 25  
Waveform is same as above on SW2

Step 6 TURN SW3 to 4 TURN SW2 to 1

SW3 puts 1.5V- on tab 5

SW2 looks at Tab 12

Verify waveform below



MAKE SURE SW1 ON

TEST BOX IS IN OPEN POS.

Verify that output ramps up and down  
with amplitude of 8V min.

Verify  $t_s$  and  $t_r$

combined are not greater than 2.0 milliseconds.

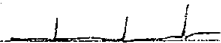
If not correct this can be corrected by changing  
T212 and replacing R207 with a <sup>PRES. RES OR POT</sup> 5K pot. Set  
pot to 5K and adjust to get correct waveform  
above

Step 6 TURN SW3 to 4 TURN SW2 to 3

SW3 puts 1.5V- on tab 5

SW2 looks across tab 14 and 17

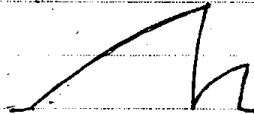
Verify waveform below



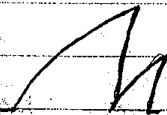
TURN SW2 to 4 SW2 is looking across tab 13 and 15

Verify waveform is same as above or like. SW2 to 6

Step 7 Turn SW 3 to 9 Turn SW2 to 2  
Measure from TP1 to TP5 adjust P2  
to 0V. Observe scope and adjust P2 till waveform below  
appears approx. .1V- to .2V- at TP5 will cause this to happen  
Slowly adjust P2 down until no output is observed on  
scope. Output on scope should be zero before .1V-  
at TP5. Readjust TP5 to -0.57V-



Step 8 Turn SW 3 to 8 Turn SW2 to 1  
Measure from TP1 to TP7 Adjust P1 to 0V.  
Observe scope and adjust P1 till waveform  
below appears approx. .1V+ to .2V+ at TP7 will cause this to happen  
Slowly adjust P1 down until no output is observed on scope.  
Output on scope should be zero before .1V+ at TP7.  
Readjust TP7 to 0.57V+





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**6.3   \*\*\*TEST COMPLETE \*\*\***

**7.   NOTES**